	Search Notes			Application/Control No.	Applicant(s)/Patent under Reexamination
				10/750,355	MATHIEU ET AL.
				Examiner	Art Unit
				Edwin A. León	2833

SEARCHED			
Class	Subclass	Date	Examiner
439	69	3/11/2006	EAL
	662		
	81-83		
	515		
4plct	srnch	10/11/05	BmL
4plct	Slonch	4/29/06	mL
4punth	slarch	10/1/06	mL
4 6 H	slrsh	2/29/07	mL
4plct	slarch	9/13/07	mL

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR